Sheet 1 of 1 SERIAL NO. Unknown FORM PTO-1449 SAMUELS, GAUTHIER & STEVENS LLP ATTORNEY DOCKET NO. 5656 2874 Unknown 225 Franklin Street, Boston, MA 02110 (Rev. 5/92) Telephone: (617) 426-9180 Mekis et al. APPLICANT GROUP tennife INFORMATION DISCLOSURE Herewith STATEMENT BY APPLICANT FILING DATE EXAMINER U.S. PATENT DOCUMENTS EXAMINER DOCUMENT FILING DATE SUBCLASS IF APPROPRIATE CLASS NUMBER DATE NAME INITIAL λA AB AC FOREIGN PATENT DOCUMENTS **EXAMINER** DOCUMENT TRANSLATION NUMBER DATE COUNTRY CLASS SUBCLASS AĐ. AE AF OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.) EXAMINER INITIAL "Microcavities in photonic crystals: Mode symmetry, tenability, and coupling efficiency", Villeneuve et al., Physical Review B. Volume 54, No. 11, September 15, 1996, The American Physical Society, pgs: JD "Whispering-gallery mode microdisk lasers", McCall et al., Appl. Phys. Lett., January 20, 1992, АH JD American Institute of Physics, pgs: 289-291 "Surface-roughness-induced contradirectional coupling in ring and disk resonators", Little et al., Optics Letters, Vol. 22, No. 1, January 1, 1997; 1997 Optical Society of America; pgs: 4-6 AJ J)) Quided and defect modes in periodic dielectric waveguides"; Fan et al., 1995 Optical Society of AJ America, Vol. 12, No. 7, pgs: 1267-1272 M "Air-bridge microcavities", Villeneuve et al., 1995 American Institute of Physics, Appl. Phys. Lett. 67, July 10, 1995, pgs: 167-169 ٨K J) Guided Modes in Photonic Crystal Slabs" Physical Review B, Volume 60, No. 8, August 15, 1999, The ٨L JI) American Physical Society, pgs: 5751-5758 "Three-dimensional photon confinement in photonic crystals of low-dimensional periodicity", Villeneuve et al., Vol. 145, No. 6, December 1998, pgs: 384-390 AM A) "Radiation losses of waveguide-based two-dimensional photonic crystals: Positive role of the substrate", Benisty et al., Applied physics Letters, Vol. 76, No. 5, January 31, 2000, pgs 532-534 JV "Defect modes of a two-dimensional photonic crystal in an optically thin dielectric slab", Painter et al., 1999 Optical Society of America, Vol. 16, No. 2, February 1999, pgs: 275-285 J) "Multiple-cancellation mechanism for high-Q cavities in the absence of a complete photonic band gap", Johnson et al., Applied Physics Letters, Vol. 78, NO. 22, May 28, 2001, pgs: 3388-3390
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